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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

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Kuzby	t et al.) Group Art Unit: Unassigned)
Applic	eation No.: 10/721,235) Examiner: Unassigned) Confirmation No.: Unassigned
Filed:	November 26, 2003)
For:	SYSTEM AND METHOD FOR NON- DESTRUCTIVE IMPLANTATION CHARACTERIZATION OF QUIESCENT MATERIAL))))
	INFORMATION DISCI TRANSMITT	
P.O. B	dissioner for Patents Box 1450 adria, VA 22313-1450	
Sir:	ş*	
above-	Enclosed is an Information Disclosure Statidentified patent application.	ement and accompanying form PTO-1449 for the
	[X] No additional fee for submission o	f an IDS is required.
	[] The fee of as set forth in 3	7 C.F.R. § 1.17(p) is also enclosed.
	[] Charge \$to Deposit	Account No. 02-4800 for the fee due.
,	[] A check in the amount of \$	is enclosed for the fee due.
	The Director is hereby authorized to charg and 1.21 that may be required by this paper, at No. 02-4800. This paper is submitted in	
	Respectful	ly submitted,
	BURNS, D	OOANE, SWECKER & MATHIS, LLP
Date:	T. Ge Regis Redw (650)	ene Dillahunty tration No. 21,423 tood Shores, California Office 622-2300
	lox 1404 Idria, Virginia 22313-1404	



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	DESTRUCTIVE IMPLANTATION)	
	CHARACTERIZATION OF)	
	QUIESCENT MATERIAL)	

FIRST INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

In accordance with the duty of disclosure as set forth in 37 C.F.R. § 1.56, Applicants submit the following information in conformance with 37 C.F.R. §§ 1.97 and 1.98.

U.S. Patent Documents

4,953,983	Bottka et al.	9/4/90
5,034,611	Alpern et al.	7/23/91
5,769,540	Schietinger et al.	6/23/98
6,573,999	Yang	6/3/03
2002/0057437	McMillen et al.	5/16/02
2002/0080356	McMillen et al.	6/27/02

Non Patent Literature Documents

Rendon, "Optical Densitometry as a Monitor for Sub 5keV Implants," IEEE, 1999, pp. 602-605

Information Disclosure Statement Application No. 10/721,235 Attorney's Docket No. 033915-002

Page 2

Pursuant to 37 C.F.R. § 1.98, a copy of each of the documents cited is enclosed.

However, copies of the listed U.S. patents and U.S. patent application publications are not enclosed since it is no longer required according to the July 11, 2003 waiver of the requirement for copies of cited U.S. patents and U.S. patent application publications in national patent applications filed after June 30, 2003 and international applications entering the national stage under 35 U.S.C. § 371 after June 30, 2003.

The documents are being submitted within three (3) months of the filing or entry of the national stage of this application or before the first Office Action on the merits, whichever is later. Since the documents are being filed within the time period set forth in 37 C.F.R. § 1.97(b) no fee or statement is required.

To assist the Examiner, the documents are listed on the attached form PTO-1449. It is respectfully requested that an Examiner-initialed copy of this form be returned to the undersigned.

Respectfully submitted,

BURNS, DOANE, SWECKER & MATHIS, LLP

Date: 2/25/04

T. Gene Dillahunty

Registration No.25,423

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Alexandria, Virginia 22313-1404

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Substitute for forms 1449A/PTO & 1449B/PTO				ATTORNEY'S DKT No. 033915-002	APPLICA 10/721,2		lo.		
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FIRST INFORMATION DISCLOSURE				Kuzbyt et al.					
STATEMENT BY APPLICANT			FILING DATE GROUP						
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DEWIT	Document Kind Code Na			ame of Patentee or Applicant			Issue/Publication Date		
Examiner Initials	Document Number	(if known)	of Cited Document			(MM-DD-YYYY)			
	4,953,983	356/45	Bottka et al.	ottka et al.			9/4/90		
	5,034,611	250/372	Alpern et al.	Alpern et al.			7/23/91		
	5,769,540	374/127	Schietinger et	Schietinger et al.			6/23/98		
	6,573,999	356,632	Yang				6/3/03		
	2002/0057437		McMillen et al.				5/16/02		
	2002/0080356		McMillen et al.				6/27/02		
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		NON PA	TENT LITERA	TURE DOCUMENTS	_				
	Include	e name of autho	r (in CAPITAL LETT	TERS), title of the article (whe	n appropriate), titl	e of the	•		
Examiner	item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s),								
Initials _	publisher, city and/or country where published. RENDON, "Optical Densitometry as a Monitor for Sub 5keV Implants", IEEE, 1999, pp. 602-605								
	TALINE ON THE PROPERTY OF THE PARTY OF THE P	ononomou y do c		, , , , , , , , , , , , , , , , , , ,					
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Examiner Signature EXAMINER: Initial if reference considered, whether or not citation is in conformance with M.P.E.P. § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. SEND TO: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

Date Considered